MOSFETs Silicon N-Channel MOS (DTMOSIV)

# **TK10A80W**

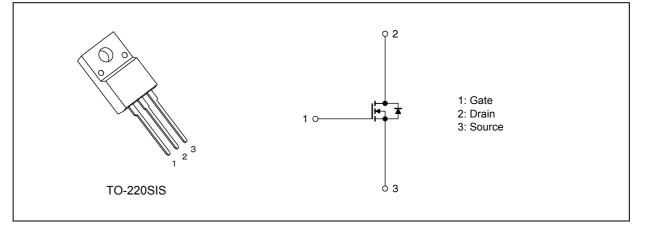
#### 1. Applications

Switching Voltage Regulators

#### 2. Features

- (1) Low drain-source on-resistance:  $R_{DS(ON)} = 0.46 \Omega$  (typ.) by using Super Junction Structure : DTMOS
- (2) Easy to control Gate switching
- (3) Enhancement mode:  $V_{th}$  = 3.0 to 4.0 V ( $V_{DS}$  = 10 V,  $I_D$  = 0.45mA)

### 3. Packaging and Internal Circuit



### 4. Absolute Maximum Ratings (Note) (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V <sub>DSS</sub>	800	V
Gate-source voltage		V <sub>GSS</sub>	±20	1
Drain current (DC)	(Note 1)	Ι <sub>D</sub>	9.5	Α
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	38	1
Power dissipation (T	<sub>c</sub> = 25°C)	PD	40	W
Single-pulse avalanche energy	(Note 2)	E <sub>AS</sub>	332	mJ
Single-pulse avalanche current		I <sub>AS</sub>	1.9	Α
Reverse drain current (DC)	(Note 1)	I <sub>DR</sub>	9.5	1
Reverse drain current (pulsed)	(Note 1)	I <sub>DRP</sub>	38	1
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature		T <sub>stg</sub>	-55 to 150	1
Isolation voltage (RMS) (t	= 1.0 s)	V <sub>ISO(RMS)</sub>	2000	V
Mounting torque		TOR	0.6	N · m

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Start of commercial production

#### 5. Thermal Characteristics

Characteristics	Symbol	Max	Unit
Channel-to-case thermal resistance	R <sub>th(ch-c)</sub>	3.12	°C/W
Channel-to-ambient thermal resistance	R <sub>th(ch-a)</sub>	62.5	

Note 1: Ensure that the channel temperature does not exceed 150 °C.

Note 2: V<sub>DD</sub> = 90 V, T<sub>ch</sub> = 25 °C (initial), L = 167 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AS</sub> = 1.9 A

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

#### 6. Electrical Characteristics

## 6.1. Static Characteristics (Ta = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS}$ = ±20 V, $V_{DS}$ = 0 V	_	_	±1	μA
Drain cut-off current	I <sub>DSS</sub>	$V_{DS}$ = 800 V, $V_{GS}$ = 0 V	_	_	10	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	800	_	—	V
Gate threshold voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.45 mA	3.0	—	4.0	
Drain-source on-resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.8 A		0.46	0.55	Ω

### 6.2. Dynamic Characteristics (Ta = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	1150	_	pF
Reverse transfer capacitance	C <sub>rss</sub>	1	_	2	_	
Output capacitance	C <sub>oss</sub>		_	27	_	
Effective output capacitance	C <sub>o(er)</sub>	$V_{DS}$ = 0 to 640 V, $V_{GS}$ = 0 V	—	29		
Gate resistance	r <sub>g</sub>	V <sub>DS</sub> = OPEN , f = 1 MHz	_	35.0	_	Ω
Switching time (rise time)	tr	See Figure 6.2.1	_	35	_	ns
Switching time (turn-on time)	t <sub>on</sub>	1	_	65	_	
Switching time (fall time)	t <sub>f</sub>		_	10	_	
Switching time (turn-off time)	t <sub>off</sub>	1		120	_	
MOSFET dv/dt ruggedness	dv/dt	$V_{DS} \le V_{(BR)DSS}, I_D \le 9.5 A$	50	_		V/ns

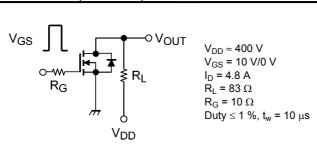


Fig. 6.2.1 Switching Time Test Circuit

### 6.3. Gate Charge Characteristics ( $T_a = 25$ °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	$V_{DD} \approx 640 \text{ V}, \text{ V}_{GS}$ = 10 V, I <sub>D</sub> = 9.5 A		19	—	nC
Gate-source charge 1	Q <sub>gs1</sub>		_	7	_	
Gate-drain charge	Q <sub>gd</sub>			6	_	

## 6.4. Source-Drain Characteristics ( $T_a = 25$ °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	V <sub>DSF</sub>	I <sub>DR</sub> = 9.5 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	V <sub>DD</sub> ≈ 640 V	_	300	_	ns
Reverse recovery charge	Q <sub>rr</sub>	I <sub>DR</sub> = 4.8 A, V <sub>GS</sub> = 0 V -dI <sub>DR</sub> /dt = 100 A/μs	_	3.2	_	μC
Peak reverse recovery current	l <sub>rr</sub>		_	22	_	А
Diode dv/dt ruggedness	dv/dt	$V_{DS} \leq 640$ V, $I_{DR} \leq 4.8$ A, $V_{GS}$ = 0 V	4.5			V/ns

## 7. Marking (Note)

TOSHIBA

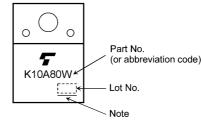


Fig. 7.1 Marking

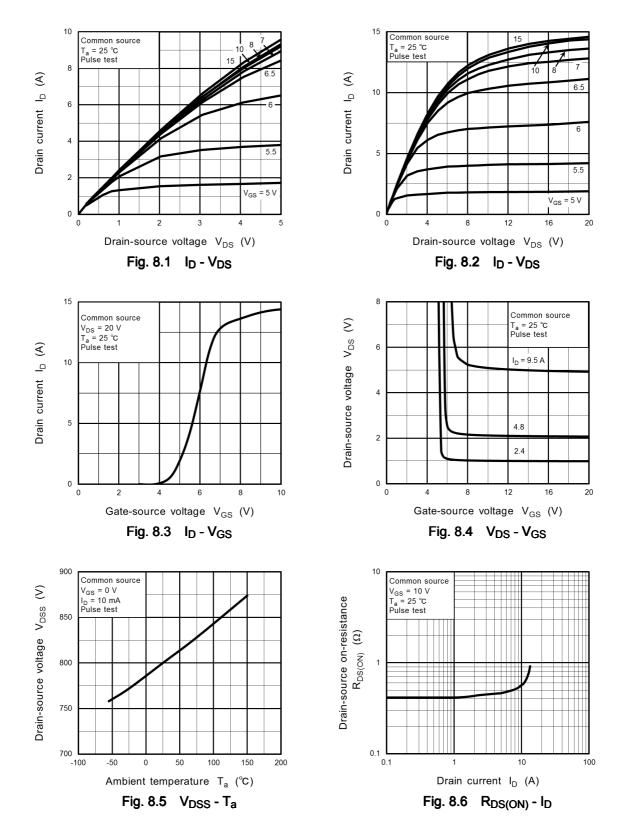
 Note:
 A line under a Lot No. identifies the indication of product Labels.

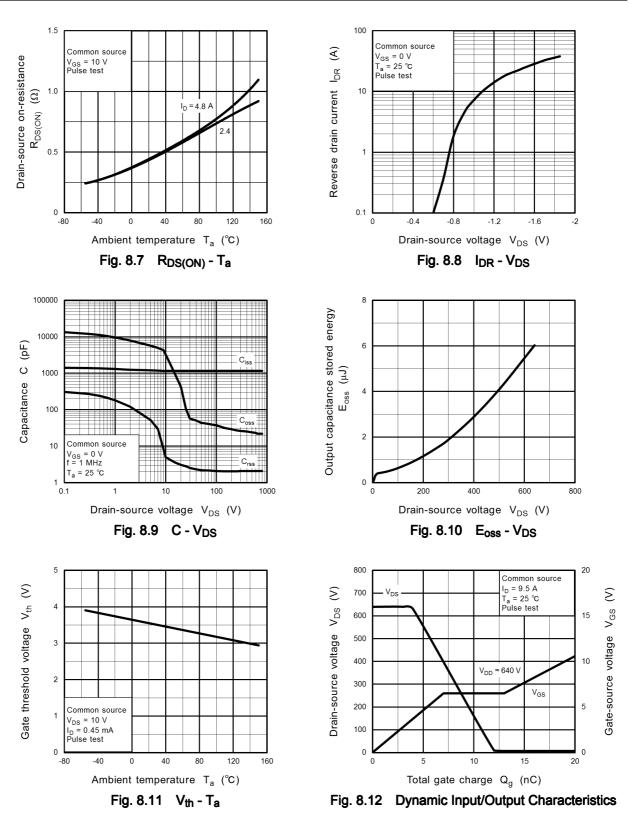
 Not underlined: [[Pb]]/INCLUDES > MCV
 Underlined: [[C]]/RoHS COMPATIBLE or [[G]]/RoHS [[Pb]]

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### 8. Characteristics Curves (Note)





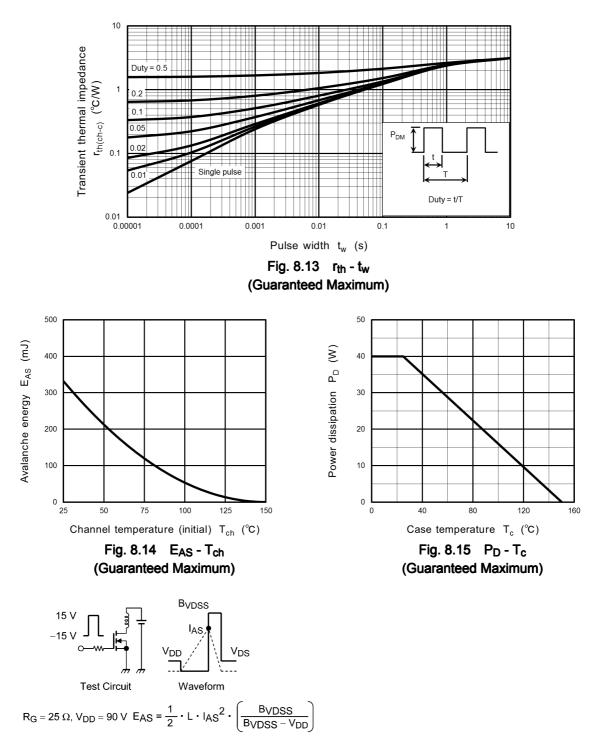
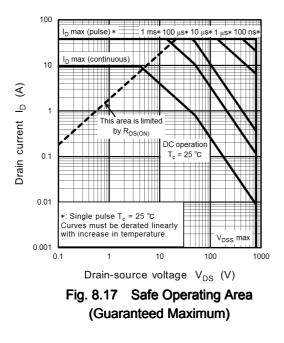


Fig. 8.16 Test Circuit/Waveform

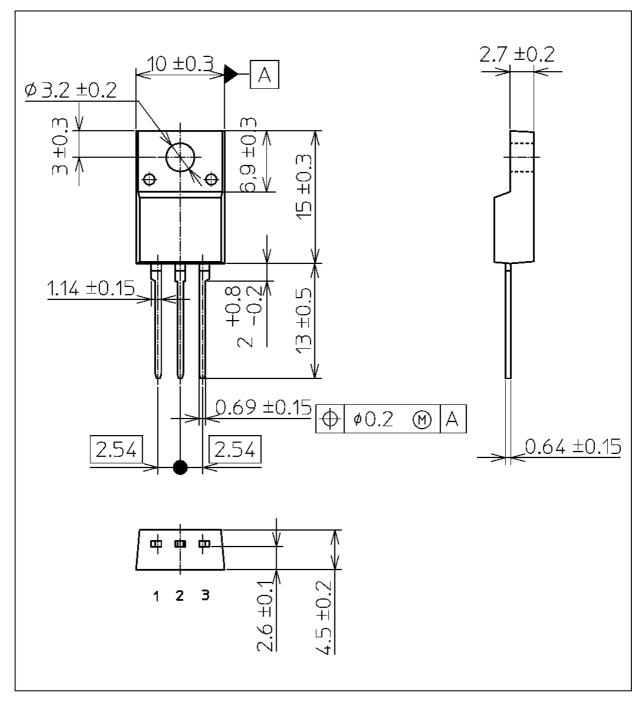


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

### Package Dimensions

TK10A80W

Unit: mm



Weight: 1.7 g (typ.)

	Package Name(s)
JEITA: SC-67	
TOSHIBA: 2-10U1S	
Nickname: TO-220SIS	

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